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Report No.: 1904RSU019-U3 Report Version: V01 Issue Date: 08-09-2019

MEASUREMENT REPORT

FCC Part 15 Subpart B / ICES-003

Applicant: Aptiv Electrical Centers (Shanghai) Co.,Ltd

Address: Zone A, Building 7, No.60, Yuanguo Road, Anting Town,

Jiading District, Shanghai, China

Application Type: Supplier Declaration of Conformity

Product: Wireless Charging

Model No.: Wireless Charging without NFC

FCC Rule Part(s): FCC Part 15 Subpart B: 2018

IC Rule Part(s): ICES-003 Issue 6 Class B

Test Procedure(s): ANSI C63.4: 2014

Result: Complies

Test Date: May 27 ~ July 30, 2019

Reviewed By

Approved By

(Robin Wu)



The test results relate only to the samples tested.

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in ANSI C63.4-2014. Test results reported herein relate only to the item(s) tested.

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Page Number: 1 of 23



Revision History

Report No.	Version	Description	Issue Date	Note
1904RSU019-U3	Rev. 01	Initial Report	08-09-2019	Valid

Page Number: 2 of 23



CONTENTS

Des	scription	on	Page
§2.1	1033 G	Seneral Information	4
1.	INTR	RODUCTION	5
	1.1.	Scope	5
	1.2.	MRT Test Location	
2.	PRO	DUCT INFORMATION	6
	2.1.	Equipment Description	6
	2.2.	Test Mode	
	2.3.	Configuration of Tested System	7
	2.4.	Test System Details	7
	2.5.	Test Software	7
	2.6.	EMI Suppression Device(s)/Modifications	8
3.	DES	CRIPTION OF TEST	9
	3.1.	Evaluation Procedure	9
	3.2.	AC Line Conducted Emissions	9
	3.3.	Radiated Emissions	10
4.	TEST	T EQUIPMENT CALIBRATION DATE	11
5.	MEA	SUREMENT UNCERTAINTY	12
6.	TEST	T RESULT	13
	6.1.	Summary	13
	6.2.	Conducted Emission Measurement	14
	6.2.1.	. Test Limit	14
	6.2.2.	. Test Setup	14
	6.2.3.	. Test Result	14
	6.3.	Radiated Emission Measurement	15
	6.3.1.	. Test Limit	15
	6.3.2.	. Test Frequency selected	15
	6.3.3.	. Test Setup	16
	6.3.4.	Test Result	17
7.	CON	ICLUSION	21
Арр	endix	A - Test Setup Photograph	22
Apr	endix	B - EUT Photograph	23



§2.1033 General Information

Applicant:	Aptiv Electrical Centers (Shanghai) Co.,Ltd			
Applicant Address:	Zone A, Building 7, No.60, Yuanguo Road, Anting Town, Jiading			
	District, Shanghai, China			
Manufacturer:	Aptiv Electrical Centers (Shanghai) Co.,Ltd			
Manufacturer Address:	Zone A, Building 7, No.60, Yuanguo Road, Anting Town, Jiading			
	District, Shanghai, China			
Test Site:	MRT Technology (Suzhou) Co., Ltd			
Test Site Address:	D8 Building, No.2 Tian'edang Rd., Wuzhong Economic Development			
	Zone, Suzhou, China			

Test Facility / Accreditations

Measurements were performed at MRT Laboratory located in Tian'edang Rd., Suzhou, China.

- MRT facility is a FCC registered (MRT Reg. No. 893164) test facility with the site description report on file and has met all the requirements specified in ANSI C63.4-2014.
- MRT facility is an IC registered (MRT Reg. No. 11384A-1) test laboratory with the site description on file at Industry Canada.
- MRT facility is a VCCI registered (R-20025, G-20034, C-20020, T-20020) test laboratory with the site description on file at VCCI Council.
- MRT Lab is accredited to ISO 17025 by the American Association for Laboratory Accreditation (A2LA) under the American Association for Laboratory Accreditation Program (A2LA Cert. No. 3628.01) in EMC, Telecommunications, Radio and SAR testing.





1. INTRODUCTION

1.1. Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

1.2. MRT Test Location

The map below shows the location of the MRT LABORATORY, its proximity to the Taihu Lake. These measurement tests were conducted at the MRT Technology (Suzhou) Co., Ltd. Facility located at D8 Building, No.2 Tian'edang Rd., Wuzhong Economic Development Zone, Suzhou, China. The measurement facility compliant with the test site requirements specified in ANSI C63.4-2014.





2. PRODUCT INFORMATION

2.1. Equipment Description

Product Name:	Wireless Charging
Model No.:	Wireless Charging without NFC
Working Center Frequency:	120KHz for android
	127.7KHz for IOS
Modulation Type:	FSK
Working Voltage:	DC 12V

2.2. Test Mode

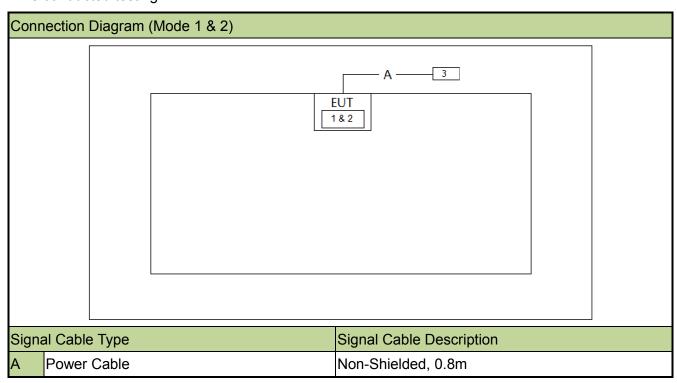
Final Test Mode:	Mode 1: Charging for Android smart phone with EUT		
Filial Test Mode.	Mode 2: Charging for IOS smart phone with EUT		

Page Number: 6 of 23



2.3. Configuration of Tested System

The EUT was tested per the guidance FCC Part 15 Subpart B: 2018 & ICES-003 Issue 6 Class B and ANSI C63.4: 2014 was used to reference the appropriate EUT setup for radiated testing and AC line conducted testing.



2.4. Test System Details

The types for all equipments, plus descriptions of all cables used in the tested system (including inserted cards) are:

Prod	uct	Manufacturer	Model No.	Serial No.	Power Cord
1	Smart Phone	HUAWEI	Meta 20	N/A	N/A
2	Smart Phone	Apple	A1865	N/A	N/A
3	DC Power Supply	GWINSTEK	DPS-3303C	EM913553	N/A

2.5. Test Software

1	Setup the EUT and simulators as shown on above.			
2	a. Charging for Android smart phone with EUT			
b. Charging for IOS smart phone with EUT				
3	Make the EUT working on each mode, and turn to test			



2.6. EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and/or no modifications were made during testing.

Page Number: 8 of 23



3. DESCRIPTION OF TEST

3.1. Evaluation Procedure

The measurement procedures described in the American National Standard for Methods of Measurement of Radio-Noise Emission from Low-Voltage Electrical Equipment in the Range of 9kHz to 18GHz (ANSI C63.4-2014) was used in the measurement of the Equipment under test.

Deviation from measurement procedure......None

3.2. AC Line Conducted Emissions

The line-conducted facility is located inside an 8'x4'x4' shielded enclosure. A 1m x 2m wooden table 80cm high is placed 40cm away from the vertical wall and 80cm away from the sidewall of the shielded room. Two 10kHz-30MHz, $50\Omega/50$ uH Line-Impedance Stabilization Networks (LISNs) are bonded to the shielded room floor. Power to the LISNs is filtered by external high-current high-insertion loss power line filters. These filters attenuate ambient signal noise from entering the measurement lines. These filters are also bonded to the shielded enclosure.

The EUT is powered from one LISN and the support equipment is powered from the second LISN. If the EUT is a DC-powered device, power will be derived from the source power supply it normally will be powered from and this supply line(s) will be connected to the second LISN. All interconnecting cables more than 1 meter were shortened to a 1 meter length by non-inductive bundling (serpentine fashion) and draped over the back edge of the test table. All cables were at least 40cm above the horizontal reference ground-plane. Power cables for support equipment were routed down to the second LISN while ensuring that that cables were not draped over the second LISN. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the receiver and exploratory measurements were made to determine the frequencies producing the maximum emission from the EUT. The receiver was scanned from 150 kHz to 30 MHz. The detector function was set to peak mode for exploratory measurements while the bandwidth of the analyzer was set to 9 kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Each emission was also maximized by varying: power lines, the mode of operation or resolution, clock or data exchange speed, scrolling H pattern to the EUT and/or support equipment whichever determined the worst-case emission. Once the worst case emissions have been identified, the one EUT cable configuration/arrangement and mode of

operation that produced these emissions are used for final measurements on the same test site.



3.3. Radiated Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. An MF Model 210SS turntable is used for radiated measurement. It is a continuously rotatable, remote controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm high PVC support structure is placed on top of the turntable. For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30 MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30 MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up was placed on top of the 0.8 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, mode of operation, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found. Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, whichever produced the worst-case emissions. According to 3dB beam-width of horn antenna, the horn antenna should be always directed to the EUT when rising height.



4. TEST EQUIPMENT CALIBRATION DATE

Conducted Emissions - SR2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
EMI Test Receiver	R&S	ESR3	MRTSUE06185	1 year	2020/04/15
Two-Line V-Network	R&S	ENV 216	MRTSUE06002	1 year	2020/06/13
Two-Line V-Network	R&S	ENV 216	MRTSUE06003	1 year	2020/06/13
Thermohygrometer	Testo	608-H1	MRTSUE06404	1 year	2019/08/14
Shielding Chamber	MIX-BEP	Chamber-SR2	MRTSUE06215	N/A	N/A

Radiated Emissions - AC1

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
EMI Test Receiver	R&S	ESR7	MRTSUE06001	1 year	2019/08/13
PXA Signal Analyzer	Keysight	9030B	MRTSUE06395	1 year	2019/09/25
Loop Antenna	Schwarzbeck	FMZB 1519	MRTSUE06025	1 year	2019/11/09
Bilog Period Antenna	Schwarzbeck	VULB 9168	MRTSUE06172	1 year	2020/03/31
Broad Band Horn Antenna	Schwarzbeck	BBHA 9120D	MRTSUE06023	1 year	2019/10/19
Broad Band Horn Antenna	Schwarzbeck	BBHA 9170	MRTSUE06024	1 year	2019/12/17
Microwave System Amplifier	Agilent	83017A	MRTSUE06076	1 year	2019/11/16
Preamplifier	Schwarzbeck	BBV 9721	MRTSUE06121	1 year	2020/06/11
Thermohygrometer	Testo	608-H1	MRTSUE06403	1 year	2019/08/14
Anechoic Chamber	TDK	Chamber-AC1	MRTSUE06212	1 year	2020/04/30

Radiated Emission - AC2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Spectrum Analyzer	Keysight	N9038A	MRTSUE06125	1 year	2019/08/13
Loop Antenna	Schwarzbeck	FMZB 1519	MRTSUE06025	1 year	2019/11/09
Bilog Period Antenna	Schwarzbeck	VULB 9162	MRTSUE06022	1 year	2019/10/19
Horn Antenna	Schwarzbeck	BBHA9120D	MRTSUE06171	1 year	2019/11/09
Broad Band Horn Antenna	Schwarzbeck	BBHA 9170	MRTSUE06024	1 year	2019/12/17
Broadband Coaxial Preamplifier	Schwarzbeck	BBV 9718	MRTSUE06176	1 year	2019/11/16
Preamplifier	Schwarzbeck	BBV 9721	MRTSUE06121	1 year	2020/06/11
Temperature/Humidity Meter	Minggao	ETH529	MRTSUE06170	1 year	2019/12/13
Anechoic Chamber	RIKEN	Chamber-AC2	MRTSUE06213	1 year	2020/04/30

Software	Version	Function
e3	V8.3.5	EMI Test Software

Page Number: 11 of 23



5. MEASUREMENT UNCERTAINTY

Where relevant, the following test uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k = 2.

Conducted Emission Measurement - SR2

The maximum measurement uncertainty is evaluated as:

9kHz~150kHz: 3.84dB 150kHz~30MHz: 3.46dB

Radiated Emission Measurement - AC1

The maximum measurement uncertainty is evaluated as:

Horizontal: 30MHz~300MHz: 4.07dB

300MHz~1GHz: 3.63dB 1GHz~18GHz: 4.16dB

Vertical: 30MHz~300MHz: 4.18dB

300MHz~1GHz: 3.60dB 1GHz~18GHz: 4.76dB

Radiated Emission Measurement - AC2

The maximum measurement uncertainty is evaluated as:

Horizontal: 30MHz~300MHz: 3.75dB

300MHz~1GHz: 3.53dB

1GHz~18GHz: 4.28dB

Vertical: 30MHz~300MHz: 3.86dB

300MHz~1GHz: 3.53dB 1GHz~18GHz: 4.33dB

Page Number: 12 of 23



6. TEST RESULT

6.1. Summary

FCC Part Section(s)	IC Part Section(s)	Test Description	Test Result
15.107	ICES-003 Issue 6 - 6.1	Conducted Emissions	N/A
15.109	ICES-003 Issue 6 - 6.2	Radiated Emissions	Pass

Note: "N/A" means that the test item is not applicable, and the detailed information refers to relevant section.

Page Number: 13 of 23



6.2. Conducted Emission Measurement

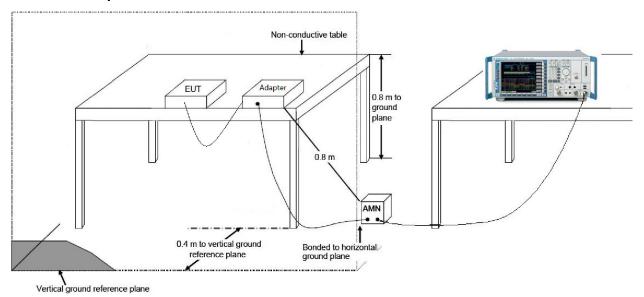
6.2.1.Test Limit

FCC 15.107 Limits									
Frequency (MHz)	QP (dBuV)	AV (dBuV)							
0.15 ~ 0.50	66 ~ 56	56 ~ 46							
0.50 ~ 5.0	56	46							
5.0 ~ 30	60	50							

Note 1: The lower limit shall apply at the transition frequencies.

Note 2: The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz.

6.2.2.Test Setup



6.2.3.Test Result

The EUT is powered by DC source, so this requirement does not apply.



6.3. Radiated Emission Measurement

6.3.1.Test Limit

FCC Part 15.109 Limits										
Frequency (MHz)	Distance (m)	Level (dBµV/m)								
30 - 88	3	40								
88 - 216	3	43.5								
216 - 960	3	46								
Above 960	3	54								

Note 1: The lower limit shall apply at the transition frequency.

Note 2: Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the device or system.

Note 3: E field strength $(dB\mu V/m) = 20 \log E$ field strength (uV/m)

6.3.2.Test Frequency selected

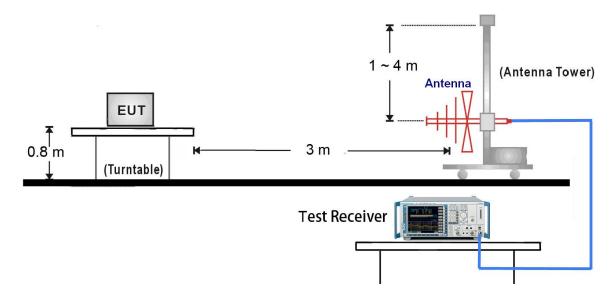
For an unintentional radiator, including a digital device, the spectrum shall be investigated from the lowest radio frequency signal generated or used in the device, without going below the lowest frequency for which a radiated emission limit is specified, up to the frequency shown in the following table:

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	30
1.705 - 108	1000
108 - 500	2000
500 - 1000	5000
Abovo 1000	5th harmonic of the highest frequency or 40
Above 1000	GHz, whichever is lower

Page Number: 15 of 23



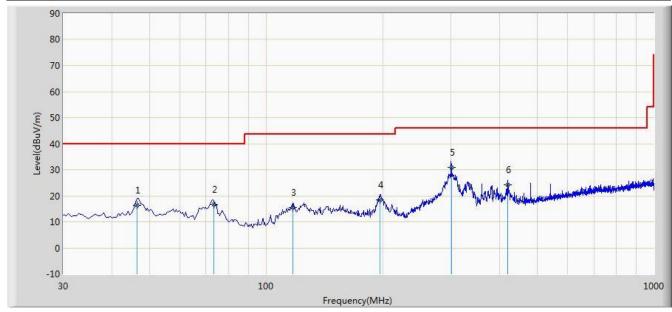
6.3.3.Test Setup





6.3.4.Test Result

Site: AC1	Time: 2019/05/27 - 14:59
Limit: FCC_Part15.109_RE(3m)_ClassB	Engineer: David Lv
Probe: VULB 9168 _20-2000MHz	Polarity: Horizontal
EUT: Wireless Charging	Power: DC 12V
Note: Mode 1	



No	Flag	Mark	Frequency	Measure	Reading	Over Limit	Limit	Factor	Туре
			(MHz)	Level	Level	(dB)	(dBuV/m)	(dB)	
				(dBuV/m)	(dBuV)				
1			46.492	16.310	2.000	-23.690	40.000	14.310	QP
2			73.452	16.580	5.420	-23.420	40.000	11.160	QP
3			117.247	15.478	2.452	-28.022	43.500	13.025	QP
4			196.452	18.365	6.854	-25.135	43.500	11.511	QP
5		*	300.452	31.002	16.452	-14.998	46.000	14.550	QP
6			420.452	24.060	6.758	-21.940	46.000	17.303	QP

Note: Measure Level (dB μ V/m) = Reading Level (dB μ V) + Factor (dB)



Site: AC1	Time: 2019/05/27 - 15:04
Limit: FCC_Part15.109_RE(3m)_ClassB	Engineer: David Lv
Probe: VULB 9168 _20-2000MHz	Polarity: Vertical
EUT: Wireless Charging	Power: DC 12V
Note: Mode 1	·

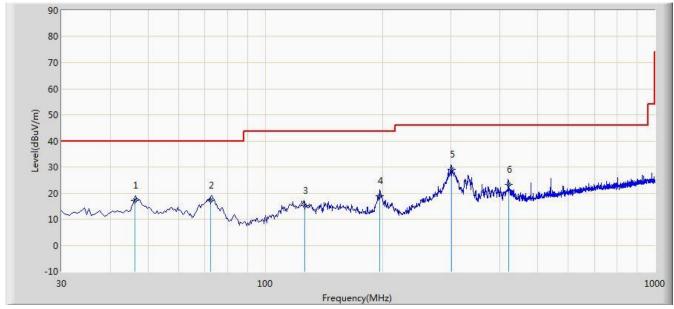
-10 Frequency(MHz)

No	Flag	Mark	Frequency	Measure	Reading	Over Limit	Limit	Factor	Туре
			(MHz)	Level	Level	(dB)	(dBuV/m)	(dB)	
				(dBuV/m)	(dBuV)				
1		*	47.755	30.125	15.845	-9.875	40.000	14.280	QP
2			59.488	26.322	12.754	-13.678	40.000	13.568	QP
3			72.456	29.847	18.542	-10.153	40.000	11.306	QP
4			126.011	25.672	11.974	-17.828	43.500	13.698	QP
5			198.199	22.385	10.970	-21.115	43.500	11.415	QP
6			300.244	24.581	10.033	-21.419	46.000	14.548	QP

Note: Measure Level (dB μ V/m) = Reading Level (dB μ V) + Factor (dB)



Site: AC1	Time: 2019/07/30 - 13:35
Limit: FCC_Part15.109_RE(3m)_ClassB	Engineer: David Lv
Probe: VULB 9168 _20-2000MHz	Polarity: Horizontal
EUT: Wireless Charging	Power: DC 12V
Note: Mode 2	

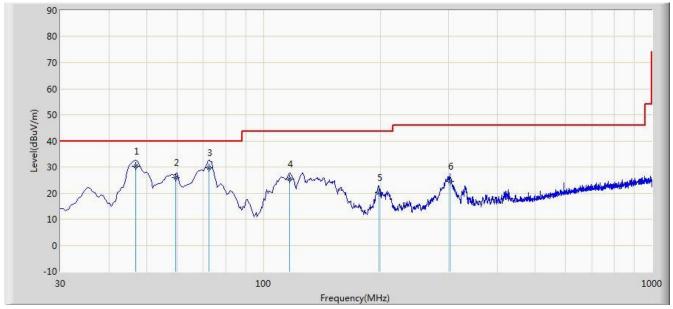


No	Flag	Mark	Frequency	Measure	Reading	Over Limit	Limit	Factor	Туре
			(MHz)	Level	Level	(dB)	(dBuV/m)	(dB)	
				(dBuV/m)	(dBuV)				
1			46.398	17.175	2.863	-22.825	40.000	14.312	QP
2			72.456	17.119	5.814	-22.881	40.000	11.306	QP
3			126.211	15.162	1.452	-28.338	43.500	13.710	QP
4			196.452	18.963	7.452	-24.537	43.500	11.511	QP
5		*	300.450	29.000	14.450	-17.000	46.000	14.550	QP
6			420.785	23.319	5.999	-22.681	46.000	17.319	QP

Note: Measure Level (dB μ V/m) = Reading Level (dB μ V) + Factor (dB)



Site: AC1	Time: 2019/07/30 - 13:35
Limit: FCC_Part15.109_RE(3m)_ClassB	Engineer: David Lv
Probe: VULB 9168 _20-2000MHz	Polarity: Vertical
EUT: Wireless Charging	Power: DC 12V
Note: Mode 2	



No	Flag	Mark	Frequency	Measure	Reading	Over Limit	over Limit Limit		Туре
			(MHz)	Level	Level	(dB)	(dBuV/m)	(dB)	
				(dBuV/m)	(dBuV)				
1		*	46.976	30.307	16.012	-9.693	40.000	14.295	QP
2			59.450	25.825	12.255	-14.175	40.000	13.571	QP
3			72.450	29.756	18.450	-10.244	40.000	11.307	QP
4			116.750	25.427	12.456	-18.073	43.500	12.971	QP
5			198.456	20.145	8.744	-23.355	43.500	11.401	QP
6			301.560	24.604	10.033	-21.396	46.000	14.571	QP

Note: Measure Level (dB μ V/m) = Reading Level (dB μ V) + Factor (dB)



7. CONCLUSION

The data co	ollected r	elate on	y the iter	n(s) test	ed and	show	that the	e unit	has l	been	tested	to c	omply
with the req	uiremen	ıts specif	ied in §1	5.107 / §	15.109	of the	e FCC F	Rules	and	ISED	Rules		

— The End



Appendix A - Test Setup Photograph

Refer to "1904RSU019-UT" file.

Page Number: 22 of 23



Appendix B - EUT Photograph

Refer to "1904RSU019-UE" file.

Page Number: 23 of 23